Difficulties and Challenge of Commercializing New Metrology

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METROLOGY IN BALANCE

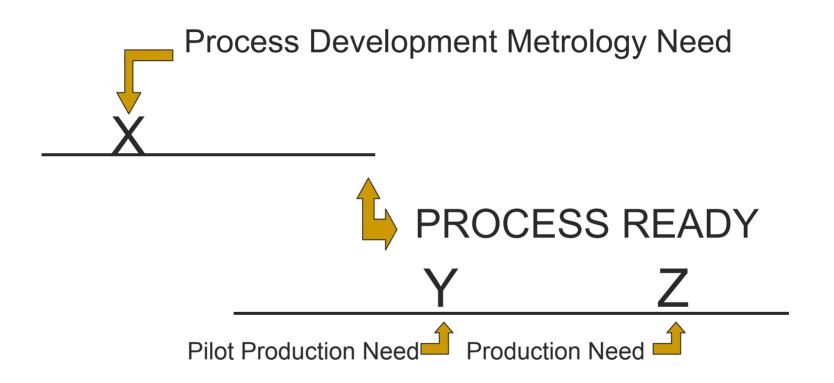


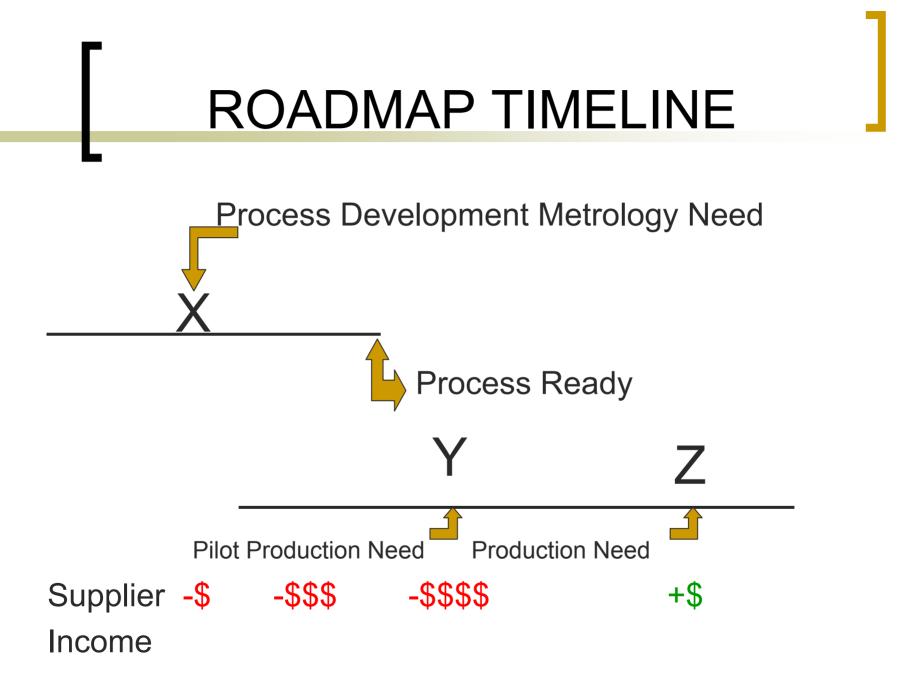
ROADMAP TIMELINE

Process Development Metrology Need



ROADMAP TIMELINE







LIKELY SUPPLIER RESPONSES

- Try to extend current equipment to meet the early need with a very small, intense team
- Try to get working prototype for pilot production need with technical risks solved

LIKELY SUPPLIER RESPONSES (Continued)

- Try to have production unit ready when production buys are real
- Some software and extra features may come later

LIKELY CUSTOMER RESPONSES

- We are accelerating our roadmap by a year
- We are moving our technical specifications forward one full roadmap node
- We want it extendable and field upgradeable for two more roadmap nodes

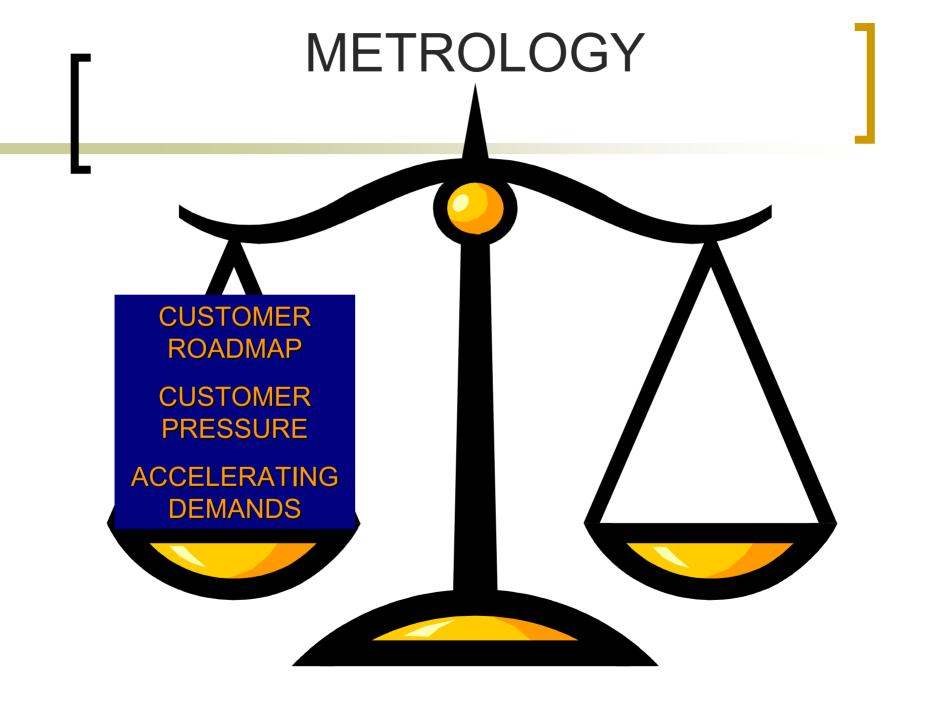
LIKELY CUSTOMER RESPONSES (Continued)

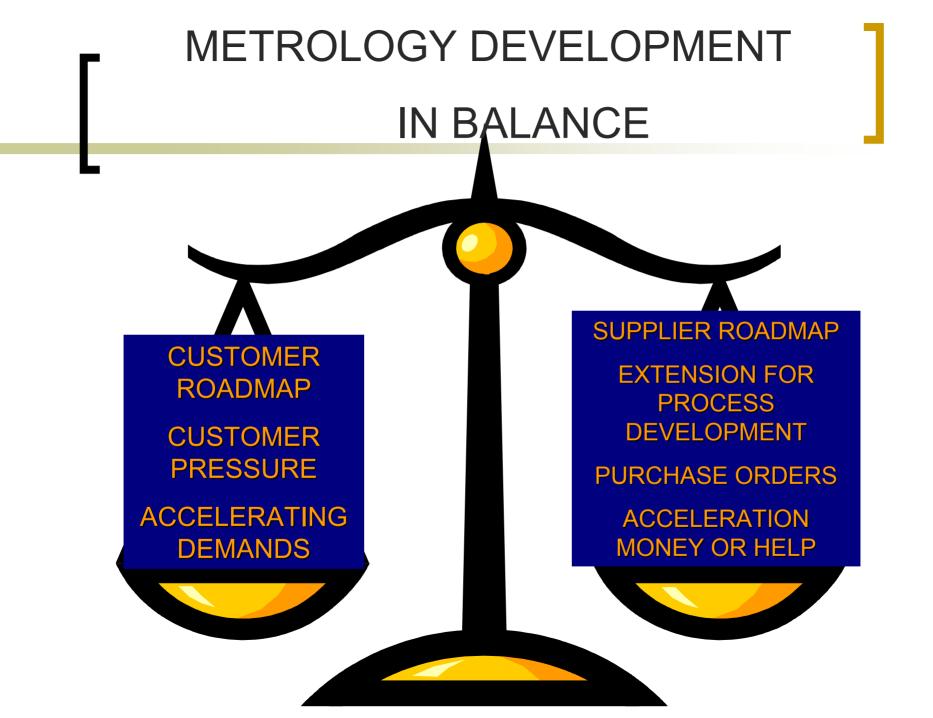
- We insist that the software and machine interface be at the new standards which we will define in about 6 months
- Within 120 days, we will define whether we want 200mm wafers, 300mm wafers or a bridge tool that can do both
- The timing of delivery is critical

TWO COMMON RESULTS:

NEW METROLOGY IS:

- Too late for the early process developers
- Too expensive for the production capital budget





EXAMPLES

MASK MAKING METROLOGY:

o D.W. Mann

Stellar Metrology — I.C. Masks Seed Funds

 Accelerating Metrology Change Customers & Sematech

Acceleration Funds and Royalties/Equity

GEMSECS: tool interface technology



• CUSTOMERS PURCHASE ORDERS

Test patterns in Kerfs and Die:

High force probe cards and high precision probers

Customer – commitment for 100 units and down payments

• OUTSOURCING SERVICES:

- Gas and Chemical Suppliers
 - pay within gas/chemical use
- Custom engineering
 - base pay plus bonus

Film Thickness in stacked layers:

- Venture Capital & IPO
- Copper dishing and erosion
 - Venture Capital

Microloop test patterns/vias:

- Self Funded
- Took 6-9 months out of process debugging/certification
- High level decision making required

300mm wafer conversion

- Group dynamic to accelerate was a wrong decision!!!!!!
- Over \$1,000,000,000 spent in conversion a generation too early!!!!!!!

Metrology "Balance in use"

- A company spent over \$100 Million Dollars on metrology and software in an advanced fab and didn't hire the people to interpret and monitor the resultant data:
 - Result: Periodic yield crashes
 Periodic chip performance problems

METROLOGY

- A company bought over \$120 Million Dollars in metrology and support software for an advanced fab and had low yields due to a design flaw.
- It took over 1 year to fund the effort to design a more error-tolerant circuit. Then the yields were higher.

The need for balance

- Clear Roadmaps
- Good Supplier Relations
- Technology
- Productivity
- Robust Performance
- Timely data interpretation/action

Management structure where smart, balanced decisions can be made.....

Do These Experiences Apply to Integrated Metrology?

- Will it increase or decrease performance?
- Will it increase or decrease productivity?
- Is it actionable within the time requested?
- Will it increase or decrease user <u>and</u> supplier profitability?